## Application/Control No. Applicant(s)/Patent Under Reexamination 10/711,899 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Long Pham 2814 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0135210 A1 07-2004 Noguchi et al. Α 257/368 US-В С US-US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S

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